Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/765,236	RATH, MATTHIAS	
Examiner	Art Unit	
Brian S. Kwon	1614	

	SEARCHED				
Class	Subclass	Date	Examiner		
514	474	3/6/2006	вк		
	725				
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
STN(resistry, caplus), EAST, NPL	3/26/2006	BLK		
Continurity Data-09/70609				
Inventor Name Search				
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